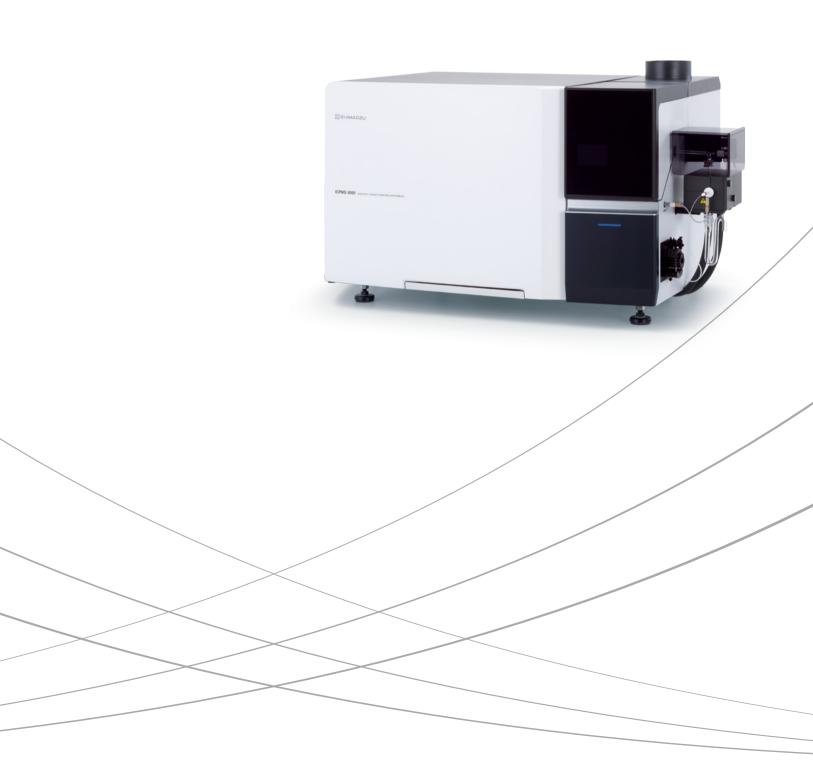


**ICP Mass Spectrometer** 

# ICPMS-2040 Series ICPMS-2050 Series



# An Era Without Compromise

## **Exceptional yet Eco Friendly**

Proprietary Advanced Mini-Torch System
Redesigned Collision/Reaction Cell
High-Performance Quadrupole Mass Filter

## **High Throughput with No Additional Cost**

"High-Speed Cell Gas Purging" Reduces Measurement Times

"ProActive Rinsing" Efficiently Rinses the Sample Introduction System

## **Minimal Operation Required**

"Extended Rinsing" Automatically Minimizes Carryover

"Preset Methods" Eliminate the Need for Method Development

# ICPMS-2040 Series ICPMS-2050 Series

ICP Mass Spectrometer



# **Exceptional yet Eco Friendly**

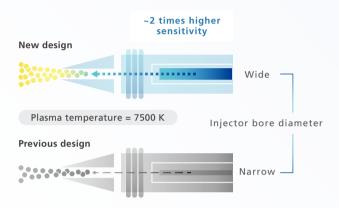
An advanced mini-torch design, combined with a redesigned collision/reaction cell, and a high-performance quadrupole mass filter result in an environmentally friendly system with superior analytical performance.



## Proprietary Advanced Mini-Torch System

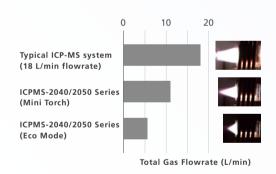
# Redeveloped High Sensitivity Mini-Torch

Optimizing the torch design keeps argon gas consumption low and decreases sample flow rate into the plasma, improving sample ionization efficiency. The new design roughly doubles sensitivity compared to previous models while reducing injector clogging issues.



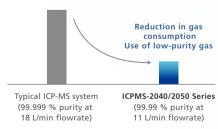
#### Low Argon Gas Consumption

A major drawback of ICP-MS systems is the large argon gas consumption. Shimadzu's mini-torch system consumes 11 L/min of argon, two-thirds the amount used by typical plasma torches. Continuous operation using a 7 m³ gas cylinder is up to 10 hours. Utilizing Eco mode (5.5 L/min plasma) during standby can further reduce argon gas consumption.



#### No Need for High-Purity Argon Gas

ICPMS-2040/2050 Series systems have a Shimadzu-made high-frequency power supply that features high-speed matching functionality, allowing for the use of low-cost, low-purity (99.95 %) argon gas to reliably generate a robust plasma.



#### Argon Gas Cost Reduction

Note: The reduction in cost will vary according to current gas pricing. This calculation assumes the price of 99.99% purity argon is two times higher than the price of 99.99% purity.

## Redesigned Collision/Reaction Cell



#### Collision Mode

Inert helium gas is introduced into the cell to selectively attenuate kinetic energies of polyatomic ions based on their sizes. These low energy ions are removed from the ion beam by applying a bias voltage at the cell exit. Because fewer by-product ions are generated, it can be used for a wide range of applications.

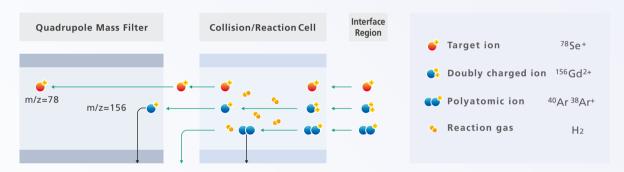
#### Online Interelement Correction (IEC)

Shimadzu's proprietary online interelement correction (IEC) function is used to correct for spectral interference that cannot be eliminated by the collision mode. By only measuring one standard sample an interference correction is calculated and applied to all samples run subsequently.

#### Reaction Mode



When a specific gas is introduced into the cell, the reaction of gas with ions is used to reduce interferences. Target ions can be analyzed with high sensitivity, while both doubly charged ions not eliminated by the collision mode and polyatomic ions can be reduced.



Note: Example of how reaction mode can be used. Reaction gas H<sub>2</sub> is used in this example to convert doubly-charged ions to singly-charged ions, and charged polyatomic ions to neutral clusters.

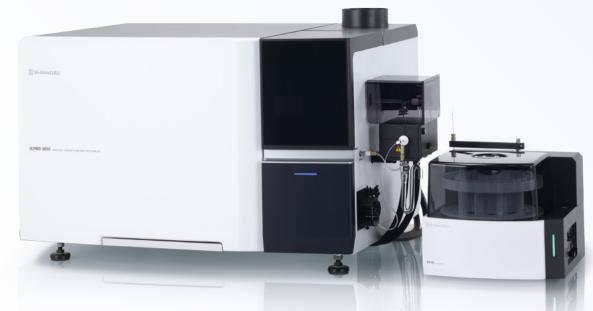
## High-Performance Quadrupole Mass Filter

#### Charge Stabilizer

To mitigate ion charge effects on the mass filter, a pulse voltage is applied between the analysis of each mass to maintain a constant charge level at the electrode surface. This improves the signal stability when analyzing samples for long periods (patent pending).

#### High-Resolution Mode and Half-Mass Correction

Masses can be analyzed at 0.5 u intervals using high-resolution mode, enabling half-mass correction for doubly charged interferences common in rare earth elements (REEs).



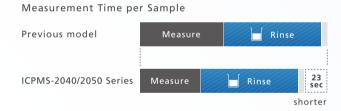
# **High Throughput with No Additional Cost**

The improved gas controller features high-speed cell gas purging. Combined with ProActive Rinsing, measurement times can be significantly shortened without any additional accessories or cost.



## High-Speed Cell Gas Purging

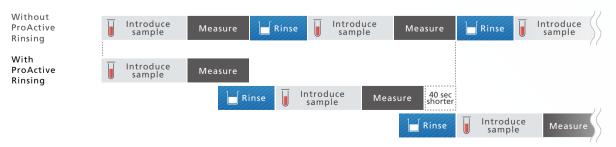
The redesigned gas controller shortens cell gas introduction and exhaust times (patent pending).



**Product** 

## **ProActive Rinsing**

While measuring multiple samples, the rinsing sequence can be started early by sending the autosampler probe to rinse while collecting data using sample already in the suction line. This greatly reduces measurement time and conserves sample.



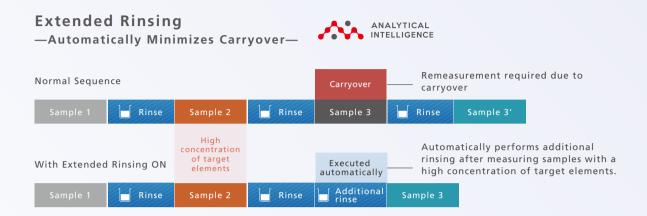
Note: The reduction in time depends on the measurement conditions. In the example above, the Preset method for Drinking Water in ICPMS-2040 was used.

# **Minimal Operation Required**

With the extended rinsing function, operators do not need to be concerned about carryover that compromises data quality.

Product - gr

Preset methods eliminate the need for method development in many applications.

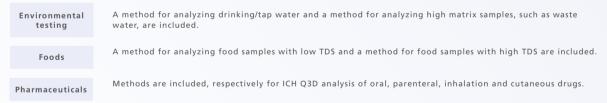


Analyzing samples containing a high concentration of target elements can cause carryover to the next sample, preventing accurate measurements. The extended rinsing function automatically performs an additional rinse sequence when a target element exceeds a predetermined upper limit. A second rinse solution can be used in the additional rinsing sequence to improve rinsing effectiveness. Consequently, carryover is eliminated to ensure high-quality data.

#### **Preset Methods**

Applications -

Preset analytical methods come configured with optimized settings, such as plasma conditions, target elements, mass information, and internal standards, for common ICPMS applications. The ICPMS-2040/2050 Series systems can therefore be used immediately after installation with minimal training.



# **Engineered for Simplicity**

## Easy-to-Maintain Sample Introduction System

## Easy-to-Access Plasma Stand

The large opening plasma stand allows effortless access to the plasma torch and interface.



# Easy-to-Remove Interface

The interface can be quickly removed without tools by simply loosening the fastening screw.

# Aerosol Dilution System

By introducing argon gas between the chamber and the torch, samples with high TDS (total dissolved solids), such as seawater, are diluted and introduced directly into the plasma.

## Peltier Cooled Cyclone Chamber

The system utilizes a high-efficiency coaxial nebulizer and electronically-cooled cyclone chamber for minimizing memory effects and increasing sample throughput.

#### **Gravity Drain**

A unique gravity drain design ensures proper draining, eliminating the need for pump tubing and concerns about plasma interruption due to flooding.



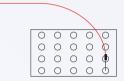
## AS-20 Autosampler

#### Rotary Design Reduces Tubing Length

The autosampler has 60 15-mL and 8 50-mL vial positions. The rotary design allows for shorter sample introduction times and can reduce memory effects.



Rotary Type (Minimizes probe tube length)



XY-Table Type
(A longer tube length is required to reach the furthest vial)



#### **Dual Rinse Port with Overflow Function**

The overflow-type rinse system includes both a standard and auxiliary port to reduce contamination between samples. An optional rinse station\* can be added for organic solvents.

\* The organic solvent rinse station does not include overflow functionality.



Rinse port

# Simple and Descriptive Maintenance Window



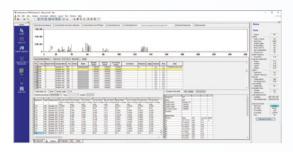
The maintenance information/setting window in new LabSolutions™ ICPMS software clearly indicates operation times of key components and automatically alerts users when it is time to maintain and/or replace parts, taking the guesswork out of maintenance.



## Software

#### New LabSolutions™ ICPMS Software

The new version of LabSolutions ICPMS software displays all necessary information in a single window, simplifying operation for new users. Experienced users can utilize advanced configurable settings for challenging applications, in-depth research and all analyses in between.



#### **Analysis Window**

The customizable analysis window can simultaneously display the current sample profile, registered samples, analytical results, errors, and instrument status. The analysis progress can be monitored at a glance. Windows can be configured and customized based on the user's preference. The assistant bar along the left side guides the users through every step of analysis in the correct order.



#### **Instrument Status Window**

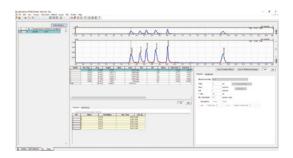
The instrument status window displays information about the instrument and accessories in a comprehensive and easy-to-understand layout.

A warning indicator is displayed if an error occurs or if a part is due for maintenance or replacement.



#### **Automatic Internal Standard Monitoring**

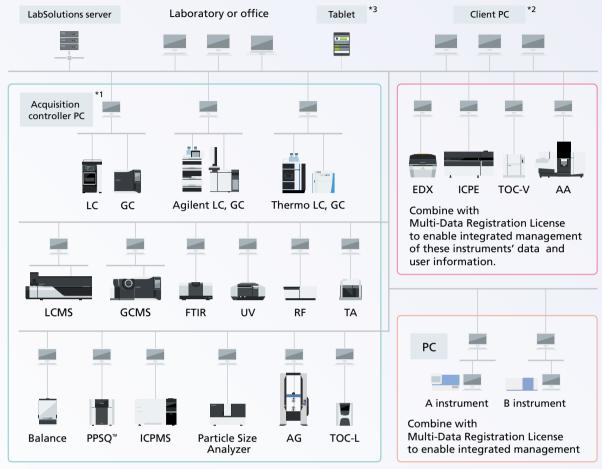
Internal standard fluctuation can be displayed as a graph for the entire analysis time, as either intensity or intensity ratio with respect to a reference sample. This helps quickly identify complications that occur due to sample matrix effects.



## LabSolutions™ ICPMS TRM (Optional)

Shimadzu LC-ICP-MS systems combined with LabSolutions ICPMS TRM software can be used to speciate arsenic, mercury, and other elements. The software controls and configures both LC and ICPMS systems in one simple platform.

## **LabSolutions™ CS Supports Laboratory Networking**



- \*1 The acquisition control PC controls analytical instruments. It can also be used to send analytical instructions and perform postrun analysis, just like a client PC.
- \*2 If a terminal service is used, then LabSolutions software does not need to be installed on client PCs.
- \*3 If an iPad is used, then XenApp from Citrix must be installed.

Adding a LabSolutions™ DB/CS connection kit (optional) enables compliance with electronic record-keeping and electronic signature regulations, such as requirements specified in FDA 21 CFR Part 11. Select either a standalone (LabSolutions DB) or networked (LabSolutions CS) system that is best for the given application. LabSolutions CS manages all analytical data in a database on a network server, so that the data can be loaded and postrun analysis can be performed on any computer connected to the network.

Note: An additional software license is required for loading data onto a computer not connected to an ICPMS-2040/2050 Series system.

#### Software Required for Connecting to LabSolutions

Name	P/N	Remarks
LabSolutions DB Connection Kit for ICPMS	211-49204-92	Standalone system
LabSolutions CS Connection Kit for ICPMS	211-49241-92	Network system
Second License for LabSolutions ICPMS	211-49245-91	Required for installing LabSolutions ICPMS on a computer other than the control computer

# **Peripheral Equipment**

#### AS-20 Autosampler (P/N 211-97400-58)

The rotary-type autosampler has 60 15-mL and 8 50-mL vial positions.

Dimensions	W290 $\times$ D508 $\times$ H300 mm (excluding arm)
Power supply	Single-phase 100-240 V, 50/60 Hz, 50 VA
Weight	11 kg (main unit)

Note: Requires a separate power cord.

Note: An additional rinsing port is optional
Rinse Port Additional Kit for AS-20 (P/N 211-97460-41).



# ASX-560 Autosampler (P/N 211-94230-01)

ASX-560 holds 240 14-mL vials and 10 50-mL vials for standards. By replacing the standard rack with a rack sold separately, 160 20-mL vials or 84 50-mL vials can be held.



Dimensions	W580 × D550 × H620 mm (including sample probe)
Power supply	100-240 V AC, 50/60 Hz, 200 VA
Weight	12 kg (main unit)

Note: Requires a separate ASX connection kit for ICPMS (P/N 211-94476-41).

# ASX-280 Autosampler (P/N 211-94412)

ASX-280 holds 120 14-mL vials and 10 50-mL vials for standards. By replacing the standard rack with a rack sold separately, 80 20-mL vials or 42 50-mL vials can be held.



Dimensions	W360 $\times$ D550 $\times$ H660 mm (including sample probe)
Power supply	100-240V AC, 50/60Hz, 200 VA
Weight	8.1 kg (main unit)

Note: Requires a separate ASX connection kit for ICPMS (P/N 211-94476-41).

# Online Internal Standard Kit (P/N 211-95010-41)

This kit is used for in-line mixing of sample and internal standard solution and introducing the mixture into the nebulizer.



# HFS-6 Hydrofluoric Acid Sample Injection System (P/N 211-93828-42)

This system is used to directly introduce samples that contain hydrofluoric acid. Fluoropolymer materials are used in the nebulizer, chamber, and drain system, whereas alumina is used in the injector unit on the torch.

# Cyclone Chamber, Quartz (P/N 211-95849)

This chamber is used to analyze trace boron, which is challenging to analyze using a standard borosilicate glass chamber.

# 3rd Gas Introduction Unit (P/N 211-96095-41)

This gas controller unit is for using a 10 % ammonia and 90 % helium gas mixture as the reaction gas in an ICPMS-2050 system.

# Organic Solvent Injection System (P/N 211-97019-41)

For analysis of organic solvents, a gas mixture of 70% argon and 30% oxygen is introduced into the torch to prevent precipitation of carbon (C) from organic solvents. This system includes a gas controller for mixed gases, a quadruple torch for organic solvents, and pump tubing for organic solvents (for ethanol/methanol/IPA).

#### Standard Torch Kit (P/N 211-97222-41)

This kit includes a torch with a 1.8 mm injector bore diameter that supports a 1.6 kW high-frequency output as well as a compatible shield screen, bonnet, and adapter.

#### Water Bubbler (P/N 204-19281)

This is used to humidify argon gas and prevent clogging of the torch and nebulizer when analyzing high TDS samples.

#### LC Connection Kit (P/N 211-96650-41)

This connection kit is required for configuring an LC-ICP-MS system that combines an ICPMS-2040/2050 Series system with a Nexera inert series or Prominence inert analysis system. For information about compatible LC systems, contact Shimadzu.

# LabSolutions ICPMS TRM (P/N 211-49200-92)

This software is for controlling Shimadzu LC and ICPMS-2040/2050 Series systems and analyzing chromatography data.

### Vacuum Pump

A rotary or dry pump is required for backing the turbomolecular pump and evacuating the interface unit. Power is supplied to the pump from the ICPMS main unit.

#### Rotary Pump, PFPE (P/N 211-90070-42)

#### Dry Pump (P/N 211-96382-91)

This pump is lubricated with a PFPE oil that allows the pump to be used for applications ranging from regular analysis to LC-ICP-MS analysis.

This oil-free dry pump has low maintenance requirements.

Dimensions	W496 × D295 × H325 mm
Weight	Approx. 50 kg

Dimensions	W494 × D217 × H301 mm
Weight	Approx. 30 kg

Name	P/N	Remarks	
Caster	225-27850-05	Rotary pump stand with caster wheels	
Noise Absorbing Box, Large	225-27850-07	Requires a separate rotary pump noise reduction box kit (P/N 211-93825-41).	
Vacuum Hose Elbow Connection	211-96090-41	Required for placing the pump under the support stand	
Long Vacuum Hose, 4 m	211-97232-42	For extending the rotary pump exhaust hose	
RP Power Cable, 3 m	211-95576-41	For extending the exhaust hose	

Cooling Water Circulator Used to cool the main unit. Select one of the following.





Note: Requires a separate chiller connection kit, SMC (P/N



Non-Freon Model Cooling Water Circulator, Apiste (P/N 211-97274-41)

Dimensions	W400 × D600 × H697 mm
Power supply	Three-phase 200 V 50/60 Hz, 1.2 kVA
Weight	58 kg



Note: Requires a separate chiller connection kit, Apiste (P/N 211-93827-42).

# **Gas-Related Equipment**

211-93827-43).

Name	P/N	Remarks
Gas Piping Connection Kit	211-97464-41	Argon gas pressure regulator and connecting components for installation directly in front of the ICPMS main unit
Regulator, LAB1-1414V	040-72030-01	Gas cylinder pressure regulator for argon gas or oxygen-argor mixture gas
Regulator, S2-1VR-1G8G-B6N1	040-72028-01	Gas cylinder pressure regulator for helium gas
Pressure Regulator for H2	221-35999-02	Gas cylinder pressure regulator for hydrogen gas
Regulator, S2-1ER-1G8G-B1N1	040-72028-31	Gas cylinder pressure regulator for third-gas
Half Union, F900-G-6.35B	035-56521-04	For connecting polypropylene tubing for argon gas or oxygen-argon mixture gas
Half Union, C1N1/4XPT1/4	035-65503	Joint for argon gas or oxygen-argon mixture gas tubing
Carrier Gas Piping with Fittings, 2.5 m	201-48067	Stainless steel tubing for helium gas lines
Gas Inlet Tubing with Fittings, 2.5 m	221-73474-25	Stainless steel tubing for hydrogen gas lines
Carrier Gas Tubing, 2 m	211-94942	Stainless steel tubing for third-gas lines
PP Tube, 44-PP White	016-43505	Polypropylene tubing for oxygen-argon mixture gas lines

Note: A hydrogen gas generator can also be used. Contact Shimadzu for further details.

# Accessories

# Sample Introduction System

	Standard Set	For Organic Solvents	For Hydrofluoric Acid Resistance
Examples of Samples	Environmental water, effluent water, solutions with dissolved pharmaceutical or food substances, or other acid decomposition solutions	Organic solvents	Solution containing hydrofluoric acid
	Mini Torch, 1.5 (P/N 211-96077)	Organic Solvent Torch (P/N 211-94021-41)	Mini Torch, HF (P/N 211-95846)
Torch	Shield Screen, Mini (P/N 211-93819)	Shield Screen, Standard (P/N 211-93820)	Shield Screen, Mini (P/N 211-93819)
	Bonnet, Mini (P/N 211-95998)	Bonnet, Standard (P/N 211-94047)	Bonnet, Mini (P/N 211-95998)
	Torch Adapter, Mini (P/N 211-93779-42)	Torch Adapter, Standard (P/N 211-93780-42)	Torch Adapter, Mini (P/N 211-93779-42)
Futurais Bira	Extension Pipe (P/N 211-95574)	-	Extension Pipe, HF (P/N 211-95847)
Extension Pipe	Dilution Gas Tube (P/N 211-95989)	•	
Chamber	Cyclone Chamber (P/N 211-96078)		Cyclone Chamber, HF (P/N 211-95848)
Chamber	Helix CT Locking Screw with S (P/N 046-00093-95)	eal	
Nebulizer	Nebulizer, DC04 (P/N 211-95988)		Nebulizer, HF (P/N 211-95845)
Nebulizer	Carrier Gas Tube (P/N 046-00092-53)	Suction Tube, NFT-050 (P/N 211-97567-41)	
Drain	Drain Trap (P/N 211-93814-01)		Drain Trap, HF (P/N 046-00093-06)
Peristaltic Pump Tube	Pump Tube, 0.76-BLK3B-95-F (P/N 018-31558-44)	Pump Tube, 0.76-BLK3B-95-SF-F (P/N 018-31558-61)*1 Pump Tube, 0.64-OW-MH-95-F (P/N 018-31558-32)*2 Pump Tube, PUR-T,381-2232F (P/N 016-46043-01)*3	Pump Tube, 0.76-BLK3B-95-F (P/N 018-31558-44)

<sup>\*1:</sup> For ethanol/methanol/IPA \*2: For DMF/NMP \*3: For xylene/kerosene

## Interface

	Standard Set	Option	
Sampling Cone	Nickel Sampling Cone (P/N 211-97283-03)	Platinum Sampling Cone (P/N 211-97283-04)	-
Skimmer Cone	Nickel Skimmer Cone, Small (P/N 211-90200-43) Used in combination with spacer for small skimmer (P/N 211-95342-01).	Platinum Skimmer Cone (P/N 211-90194-02)	Copper Skimmer Cone (P/N 211-90200-41)

# Installation

## **Installation Information**

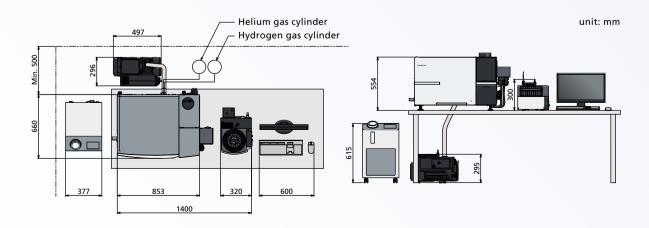
	Temperature within 18 to 28 °C (max. 2 °C/hour change)			
1. Installation Site Environment	Humidity within 20 to 70 %RH (with no condensation)			
	Avoid using the system in locations with significant vibration or dust.			
	Main unit Single-phase 200 to 240 V ± 10 %, 50/60 Hz,6 kVA			
	Data processing Single-phase 100 V ± 10 %, 50/60 Hz, 110 VA			
2. Power Supply	Cooling water Single-phase 200 to 230 V, 50/60 Hz, 1.2 kVA (standard type)			
	circulator Three-phase 200 V, 50/60 Hz, 1.2 kVA (non-CFC type)			
3. Grounding	Should be grounded with a maximum resistance of 100 $\Omega$ .			
	Type Argon gas Min. 99.95 % purity Pressure: 500 ± 10 kPa			
	Helium gas Min. 99.999 % purity Pressure: 200 ± 20 kPa			
	Hydrogen gas*1 Min. 99.999 % purity Pressure: 200 ± 20 kPa			
4. Gas Supply	Third gas*2 (gas mixture of 10 % ammonia and 90 % helium)			
	Min. 99.999 % purity Pressure: 200 ± 20 kPa			
	Oxygen-argon mixture gas <sup>*3</sup> (70 % argon and 30 % oxygen) Pressure: 450 ± 10 kPa			
5. Cooling Water	Use a dedicated cooling water circulator.			
6. Exhaust Duct	Exhaust flowrate of 2.4 to 3.3 m³/min at exhaust outlet (install a damper).			
7. Dimensions	W853 $\times$ D660 $\times$ H554 mm (excluding the plasma stand exhaust duct and other protrusions)			
8. Weight	144 kg			

Note: Refer to the pre-installation requirements for more details.

- \*1: ICPMS-2050 Series systems only
- \*2: When ICPMS-2050 Series systems are equipped with an optional third-gas system
- ${}^{\star}3$ : When an optional organic solvent injection system is installed

For more detailed system specifications, refer to the specifications sheet.

# Example of External Dimensions and Installation Configuration





- Automated support functions utilizing digital technologies, such as M2M, IoT, and Artificial Intelligence (AI), that enable higher productivity and maximum reliability.
- Allows a system to monitor and diagnose itself, handle any issues during data acquisition without user input, and automatically behave as if it were operated by an expert.
- Supports the acquisition of high quality, reproducible data regardless of an operator's skill level for both routine and demanding applications.

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